

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	397	(method with forming with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) with (clad or cladding))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/15 10:11
L2	156	((method with forming with waveguide) and (angle\$1 or mesa ramp\$2 or slop\$3) and (clad or cladding)).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/15 10:12
L3	70	((method with forming with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) same (clad or cladding))).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/11/15 10:12
S1	1	("6491447").PN.	US-PGPUB; USPAT	OR	OFF	2005/11/22 09:36

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S3	100	("4568960" "4796082" "5217943" "5593562" "4360248" "4433898" "5004317" "4530452" "4852964" "5315679" "5528712" "6012852" "5768462" "6041149" "6134356" "4400053" "4834786" "4915503" "4935045" "4946250" "5288659" "5347601" "5757986" "5790720" "5908305" "4249925" "4318058" "4318059" "4426129" "4532632" "4607912" "4784466" "4828592" "4843609" "4936645" "4953936" "4961618" "4969712" "4991921" "5011557" "5013128" "5193137" "5221633" "5223972" "5298762" "5311604" "5315672" "5358896" "5483613" "5535296").pn. ("5539850" "5627933" "5642447" "5642448" "5652814" "5654812" "5687267" "5693116" "5745631" "5756373" "5781578" "5790726" "5796905" "5809050" "5811838" "5838868" "5889904" "5903697" "5926594" "5978402" "5994679" "5999298" "5998781" "6002823" "6013025" "6021148" "6023542" "6063299" "6091870" "6108481" "6115169" "6115520" "6198858" "6341190" "6480639" "6694069" "6829398" "4972050" "5224184" "5225797" "5442475" "5537498" "5611008" "5659646" "6246098" "4403862" "4597631" "4816967" "4953930" "5266961").pn.	USPAT	OR	ON	2005/02/18 13:04
S4	269	(method with forming with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) with (clad or cladding))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 07:51
S5	2	("2001/0026669").URPN.	USPAT	OR	ON	2005/02/18 14:06
S6	101	(method with making with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) with (clad or cladding))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/18 14:39

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S7	66	S6 not (S4 or S3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/18 14:39
S8	1752	(optical with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) with (clad or cladding))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 07:51
S9	100	("4568960" "4796082" "5217943" "5593562" "4360248" "4433898" "5004317" "4530452" "4852964" "5315679" "5528712" "6012852" "5768462" "6041149" "6134356" "4400053" "4834786" "4915503" "4935045" "4946250" "5288659" "5347601" "5757986" "5790720" "5908305" "4249925" "4318058" "4318059" "4426129" "4532632" "4607912" "4784466" "4828592" "4843609" "4936645" "4953936" "4961618" "4969712" "4991921" "5011557" "5013128" "5193137" "5221633" "5223972" "5298762" "5311604" "5315672" "5358896" "5483613" "5535296").pn. ("5539850" "5627933" "5642447" "5642448" "5652814" "5654812" "5687267" "5693116" "5745631" "5756373" "5781578" "5790726" "5796905" "5809050" "5811838" "5838868" "5889904" "5903697" "5926594" "5978402" "5994679" "5999298" "5998781" "6002823" "6013025" "6021148" "6023542" "6063299" "6091870" "6108481" "6115169" "6115520" "6198858" "6341190" "6480639" "6694069" "6829398" "4972050" "5224184" "5225797" "5442475" "5537498" "5611008" "5659646" "6246098" "4403862" "4597631" "4816967" "4953930" "5266961").pn.	USPAT	OR	ON	2005/02/22 07:51
S10	269	(method with forming with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) with (clad or cladding))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 07:51

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S11	101	(method with making with waveguide) and ((angle\$1 or mesa ramp\$2 or slop\$3) with (clad or cladding))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 07:51
S12	1430	S8 not (S10 or S9 or S11)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 07:55
S13	647	S12 and "385"/.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 07:52
S14	12	("3185945" "3948583").PN. OR ("4372641").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/22 08:00
S15	11	("3992079" "4943129" "5087109" "5208882" "5473710").PN. OR ("5568579").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/22 08:21
S16	4	("3904270" "3920314").PN. OR ("3992079").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/22 08:22
S17	37	("3465159" "3589794" "3614198" "3795433" "3804489").PN. OR ("3920314").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2005/02/22 08:23
S18	0	("2005/0025408").URPN.	USPAT	OR	ON	2005/02/22 09:06
S19	368	S12 not S13	USPAT	OR	ON	2005/02/22 09:06
S20	541	S8 not S13	USPAT	OR	ON	2005/02/22 09:13
S21	278	S8 not (S13 or "372"/.ccls.)	USPAT	OR	ON	2005/02/22 09:13
S22	750	S8 not (S13 or "372"/.ccls.)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 09:14
S23	1105	S8 not S13	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 09:13

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S24	561	S8 not (S13 or "372"/.ccls. or "385"/.ccls.)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 09:15
S25	54	(US-20010026669-\$ or US-20020037022-\$ or US-20020039475-\$ or US-20030067953-\$ or US-20030081900-\$ or US-20040120677-\$ or US-20040165812-\$ or US-20020001427-\$ or US-20030223696-\$ or US-20040017962-\$ or US-20050025408-\$).did. or (US-4318058-\$ or US-4568960-\$ or US-4915503-\$ or US-4972050-\$ or US-4990465-\$ or US-5114877-\$ or US-5124543-\$ or US-5225797-\$ or US-5263111-\$ or US-5288659-\$ or US-5347601-\$ or US-5654812-\$ or US-5701379-\$ or US-5756373-\$ or US-5811838-\$ or US-5889913-\$ or US-5903697-\$ or US-5910012-\$ or US-5978402-\$ or US-6002823-\$ or US-6021148-\$ or US-6063299-\$ or US-6480639-\$ or US-6491447-\$ or US-6529667-\$ or US-6640021-\$).did. or (US-6647044-\$ or US-6741781-\$ or US-4245883-\$ or US-4372641-\$ or US-3948583-\$ or US-5276745-\$ or US-5568579-\$ or US-3992079-\$ or US-3920314-\$ or US-6607933-\$ or US-5673284-\$ or US-4547396-\$ or US-6207975-\$).did. or (EP-695958-\$).did. or (JP-57132105-\$).did. or (EP-569181-\$ or EP-695958-\$). did.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	OR	ON	2005/02/22 12:27
S26	32	S25 and ((silicon with oxynitride) or ("SiON") or (silicon with dioxide) or ("SiO.sub.2"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/02/22 12:29
S27	1	("6815266").PN.	US-PGPUB; USPAT	OR	OFF	2005/11/22 09:36

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S28	175	65/403.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 09:46
S29	301	65/386.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:11
S30	32	65/473.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:13
S31	548	438/40.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:14
S32	216	438/41.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:14
S33	198	438/43.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:17
S34	858	438/40-41,43.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:17
S35	24	S34 and (clad\$5 and core)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:17

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S36	55	(US-20010026669-\$ or US-20020001427-\$ or US-20020037022-\$ or US-20020039475-\$ or US-20030067953-\$ or US-20030081900-\$ or US-20030223696-\$ or US-20040017962-\$ or US-20040120677-\$ or US-20040165812-\$ or US-20050025408-\$).did. or (US-3920314-\$ or US-3948583-\$ or US-3992079-\$ or US-4245883-\$ or US-4318058-\$ or US-4372641-\$ or US-4547396-\$ or US-4568960-\$ or US-4915503-\$ or US-4972050-\$ or US-4990465-\$ or US-5114877-\$ or US-5124543-\$ or US-5225797-\$ or US-5263111-\$ or US-5276745-\$ or US-5288659-\$ or US-5347601-\$ or US-5568579-\$ or US-5654812-\$ or US-5673284-\$ or US-5701379-\$ or US-5756373-\$ or US-5811838-\$ or US-5889913-\$ or US-5903697-\$).did. or (US-5910012-\$ or US-5978402-\$ or US-6002823-\$ or US-6021148-\$ or US-6063299-\$ or US-6207975-\$ or US-6480639-\$ or US-6491447-\$ or US-6529667-\$ or US-6607933-\$ or US-6640021-\$ or US-6647044-\$ or US-6741781-\$ or US-5198008-\$).did. or (EP-695958-\$).did. or (JP-57132105-\$).did. or (EP-569181-\$ or EP-695958-\$). did.	US-PGPUB; USPAT; EPO; JPO; DERWENT	OR	ON	2005/11/22 10:26
S37	4	S36 and (silicon adj oxynitride)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:28
S38	14	S36 and (silicon adj dioxide)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:29

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S39	10	S36 and (clad\$5 same (silicon adj dioxide))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:32
S40	32	S36 and (angle)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:40
S41	0	((maximum near2 angle\$1) same ((index or indices) near2 refraction)) and (optical adj waveguide)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:42
S42	0	((maximum near2 angle\$1) same ((index or indices) near2 refraction))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:42
S43	49	((maximum near2 angle\$1) same ((index or indices) near2 refraction)) and (optical adj waveguide)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/22 10:42
S44	4117	385/129-132.ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 13:20
S45	8	S44 and mesa and ((silicon adj oxynitride) or ("Si.sub.2N.sub.2O"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 11:30
S46	0	S44 and mesa and ("Si.sub.2N.sub.2O")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 11:27

EAST Search History

S47	9	S44 and mesa and ((silicon adj oxynitride) or ("SiON"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 13:33
S48	1	S47 not S45	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 11:29
S49	18	S44 and (angl\$3 near2 sidewall)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 11:30
S50	0	("2005/0175286").URPN.	USPAT	OR	ON	2006/08/10 13:16
S51	171	385/129-132.ccls. and (clad\$4 with angle\$1)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 13:20
S52	194	S44 and ((silicon adj oxynitride) or ("SiON"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 13:34
S53	54	S44 and (((silicon adj oxynitride) or ("SiON"))) with (refractive near2 index))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/10 13:34
S54	1	("6169838").PN.	US-PGPUB; USPAT	OR	OFF	2006/08/14 09:16
S55	1	("6304687").PN.	US-PGPUB; USPAT	OR	OFF	2006/08/14 08:54
S56	1	("5937113").PN.	US-PGPUB; USPAT	OR	OFF	2006/08/14 08:57

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S57	43	("4696536" "4715027" "4747649" "4786133" "4938553" "5002350" "5136671" "5206920" "5325221" "5414548" "5425116" "5488680" "5526153" "5570226" "5600742" "5675675" "5684899" "5706377" "5773345" "5784507" "5799118" "5854700").PN. OR ("5937113").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/08/14 08:57
S58	856	((silic\$3 near2 resin) with (refractive adj (index or indices)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/14 09:17
S59	0	((silic\$3 near2 resin) with (refractive adj (index or indices))) same "1.415"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/14 09:17
S60	75	(refractive adj (index or indices)) same "1.415"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/14 09:17



PALM INTRANET

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Inventor Name Search Result

Your Search was:

Last Name = MCLNTYRE

First Name = THOMAS

Application#	Patent#	Status	Date Filed	Title	Inventor Name
11237120	Not Issued	30	09/28/2005	Device for treating aortic dissection	MCLNTYRE, THOMAS C.
10633071	Not Issued	80	08/01/2003	Method of forming interlayer connections in integrated optical circuits, and devices formed using same	MCLNTYRE, THOMAS J.
10655975	6969869	150	09/05/2003	PROGRAMMABLE RESISTANCE MEMORY ELEMENT WITH INDIRECT HEATING	MCLNTYRE, THOMAS J.

Inventor Search Completed: No Records to Display.

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09930348	6530287	150	08/15/2001	ALPHA-ENVIRONMENTAL CONTINUOUS AIR MONITOR INLET	RODGERS, JOHN C.
09943178	6448576	150	08/30/2001	PROGRAMMABLE CHALCOGENIDE FUSE WITHIN A SEMICONDUCTOR DEVICE	RODGERS, JOHN C.
10180645	6692994	150	06/26/2002	METHOD FOR MANUFACTURING A PROGRAMMABLE CHALCOGENIDE FUSE WITHIN A SEMICONDUCTOR DEVICE	RODGERS, JOHN C.

10331850	6815266	150	12/30/2002	METHOD FOR MANUFACTURING SIDEWALL CONTACTS FOR A CHALCOGENIDE MEMORY DEVICE	RODGERS, JOHN C.
10633071	Not Issued	80	08/01/2003	Method of forming interlayer connections in integrated optical circuits, and devices formed using same	RODGERS, JOHN C.
10655975	6969869	150	09/05/2003	PROGRAMMABLE RESISTANCE MEMORY ELEMENT WITH INDIRECT HEATING	RODGERS, JOHN C.
10831785	6909107	150	04/26/2004	METHOD FOR MANUFACTURING SIDEWALL CONTACTS FOR A CHALCOGENIDE MEMORY DEVICE	RODGERS, JOHN C.
10918814	Not Issued	71	08/12/2004	Use of radiation-hardened chalcogenide technology for spaceborne reconfigurable digital processing systems	RODGERS, JOHN C.
10967568	Not Issued	30	10/18/2004	Environmental continuous air monitor inlet with combined preseparator and virtual impactor	RODGERS, JOHN C.
11059096	Not Issued	30	02/16/2005	Continuous air monitor filter changeout apparatus	RODGERS, JOHN C.
60537866	Not Issued	159	01/20/2004	Reconfigurable processing subsystems in spaceborne applications	RODGERS, JOHN C.
07567561	5128539	150	08/15/1990	APPARATUS HAVING REDUCED BACKGROUND FOR MEASURING RADIATION ACTIVITY IN AEROSOL PARTICLES	RODGERS, JOHN C.
08003982	5337603	150	01/15/1993	ELBOW MASS FLOW METER	RODGERS, JOHN C.
08003990	5404762	150	01/15/1993	QUICK-CHANGE FILTER CARTRIDGE	RODGERS, JOHN C.

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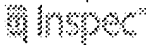
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#1 (optical and substrate and mesa and cladding<in>metadata)

#2 (optical and substrate and mesa and cladding and (remove or removed or removing)<in>metadata)

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1	INZZ	optical AND substrate AND mesa AND cladding	unrestricted	9	show titles

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- ☐ Inspec thesaurus - browse headings R-Z
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- ☐ Classification codes A: Physics, 4-5
- ☐ Classification codes A: Physics, 6
- ☐ Classification codes A: Physics, 7
- ☐ Classification codes A: Physics, 8
- ☐ Classification codes A: Physics, 9

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-  Classification codes B: Electrical & Electronics, 6-9
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